HORIBA Scientific

Ideal for low-light-level measurements in the near infrared (NIR) spectral region from 800–1700 nm Synapse Linear InGaAs Array SYN-512X1-25-1700 SYN-512X1-50-1700 SYN-1024X1-25-1700

ELEMENTAL ANALYSIS

FLUORESCENCE

GRATINGS & OEM SPECTROMETERS

OPTICAL COMPONENTS

PARTICLE CHARACTERIZATION

RAMAN

SPECTROSCOPIC ELLIPSOMETRY

SPR IMAGING

HORIBA Scientific's Synapse InGaAs arrays are the ideal choice for demanding, low-light-level measurements in the near infrared (NIR) spectral region from 800-1700 nm. Available in 512×1 (25 \times 500 μm), 512×1 (50 \times 500 μm), and 1024×1 (25 \times 500 μm) pixel formats, these InGaAs detectors provide high resolution while maintaining full well capacity. Synapse InGaAs arrays feature a 16-bit dynamic range, are deep thermoelectrically cooled, and use a mechanical shutter for subtraction of the dark background. Metal seals provide a permanent vacuum seal. A plug-and-play USB 2.0 interface allows portability and easy setup on PC notebooks and desktop computers with 100% data integrity. Applications include near-IR Raman, photoluminescence measurements of semiconductors, SWCNTs, and nanowires. Detectors with sensitivity from 1 μm to 2.2 μm are also available.



Feature	Spectroscopy Benefits		
Deep Thermoelectric Cooling	Cools the array to –60°C to minimize dark noise		
Excellent Linearity	High accuracy of data over the full dynamic range		
USB 2.0 Interface	Easy to use; connects to PC notebooks and desktops with 100% data integrity		
High Sensitivity (HiS) and High Dynamic Range (HiD) modes	Software selection of acquisition mode to optimize detector for best signal-to- noise ratio		
Auxiliary Signal Input	Unique ability to add measurements from single-channel detectors without additional electronics		
HORIBA Scientific's SynerJY® Software	Complete control of a Synapse CCD and HORIBA Scientific Spectrographsystem with full analysis capabilities		
LabVIEW VIs and SDK Available	Flexible software to integrate a Synapse CCD into existing apparatus or as an OEM component JOBIN YVON Technology		



ELEMENTAL ANALYSIS

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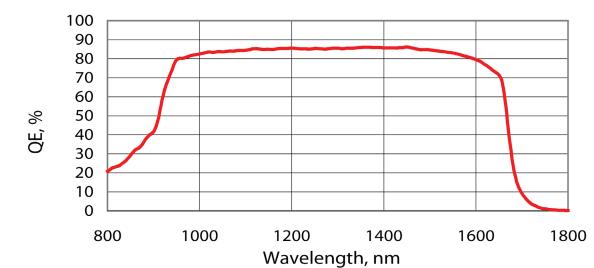
SPR IMAGING

Specifications*

Format		512 × 1	1024 × 1	
		(50 × 500)	(25 × 500)	
Wavelength Ambient Temp. (25°C)		800–1700 nm		
Operating Temp. (–60°C)	800–1650 nm			
Operating Temperature (Typical)		−60°C		
		Typical		
HiS Mode (High Gain)	0.5–0.7 ke ⁻ rms			
HiD Mode (Low Gain)	5–7 ke ⁻ rms			
HiS Mode (High Gain)	5 Me⁻			
HiD Mode (Low Gain)	130 Me ⁻			
Dark Current at -60°C		35 ke⁻/p/s		
Response Nonuniformity		± 5%	± 10%	
Response Nonlinearity		< ± 1%		
HiS Mode (High Gain)	58 e⁻/count			
HiD Mode (Low Gain)	1 <i>545</i> e⁻/count			
Dynamic Range		16 bit		
Pixel Defects		Max of 5 dark or hot pixels	Max of 10 dark or hot pixels	
	Operating Temp. (-60°C) mperature (Typical) HiS Mode (High Gain) HiD Mode (Low Gain) HiD Mode (Low Gain) -60°C uniformity linearity HiS Mode (High Gain) HiD Mode (Low Gain)	Operating Temp. (-60°C) Imperature (Typical) HiS Mode (High Gain) HiD Mode (Low Gain) HiD Mode (Low Gain) 60°C uniformity HiS Mode (High Gain) HiD Mode (Low Gain) 60°C uniformity HiS Mode (High Gain) HiD Mode (Low Gain) Max of 5 dark or hot pixels	Ambient Temp. (25°C) 800–1700 nm Operating Temp. (-60°C) 800–1650 nm mperature (Typical) -60°C Typical HiS Mode (High Gain) 0.5–0.7 ke^rms HiD Mode (Low Gain) 5–7 ke^rms HiD Mode (Low Gain) 130 Me^- HiD Mode (Low Gain) 130 Me^- HiD Mode (High Gain) ± 5% Uniformity ± 10% ± 5% HiS Mode (High Gain) 58 e^-/count HiD Mode (Low Gain) 1545 e^-/count HiD Mode (Low Gain) 16 bit Max of 5 dark or hot pixels	

*Specifications subject to change without notice.

Quantum Efficiency at 25 °C



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